Searcn Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/700,046	NAGAI ET AL.
Examiner	Art Unit
Yonel Beaulieu	3661

	SEARCHED		
Class	Subclass	Date	Examiner
701	29	10/7/2005	YB
	34		
714	. 2	10/7/2005	YB
	100		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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	CH NOTES CARCH STRATEGY	()
	DATE	EXMR
WEST (Bkwd/Fwd)	10/7/2005	YB